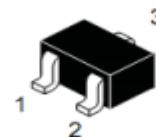


## **WPM3023**

**Single P-Channel, -30V, -3.9A, Power MOSFET**

[Http://www.sh-willsemi.com](http://www.sh-willsemi.com)

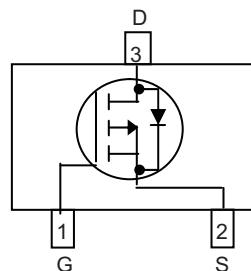
<b><math>V_{DS}</math> (V)</b>	<b>Typical <math>R_{DS(on)}</math> (mΩ)</b>
<b>-30</b>	37 @ $V_{GS}=-10V$
	50 @ $V_{GS}=-4.5V$



## **Descriptions**

The WPM3023 is P-Channel enhancement MOS Field Effect Transistor. Uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit. Standard Product WPM3023 is Pb-free.

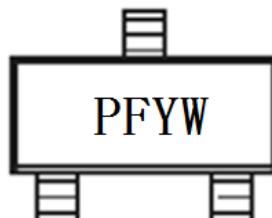
SOT-23



Pin configuration (Top view)

## Features

- Trench Technology
- Supper high density cell design
- Excellent ON resistance
- Extremely Low Threshold Voltage
- Small package SOT-23



PF = Device Code  
 Y = Year  
 W = Week(A~z)

## Applications

- DC/DC converters
- Power supply converters circuit
- Load/Power Switching for portable device

## Marking

## Order information

Device	Package	Shipping
WPM3023-3/TR	SOT-23	3000/Tape&Reel

## Absolute Maximum ratings

Parameter	Symbol	10 s	Steady State	Unit
Drain-Source Voltage	V <sub>DS</sub>	-30	±20	V
Gate-Source Voltage	V <sub>GS</sub>	±20		
Continuous Drain Current <sup>a d</sup>	I <sub>D</sub>	-3.9	-3.3	A
T <sub>A</sub> =25°C		-3.1	-2.6	
Maximum Power Dissipation <sup>a d</sup>	P <sub>D</sub>	1.2	0.9	W
T <sub>A</sub> =70°C		0.8	0.6	
Continuous Drain Current <sup>b d</sup>	I <sub>D</sub>	-3.1	-2.8	A
T <sub>A</sub> =25°C		-2.5	-2.3	
Maximum Power Dissipation <sup>b d</sup>	P <sub>D</sub>	0.8	0.7	W
T <sub>A</sub> =70°C		0.5	0.4	
Pulsed Drain Current <sup>c</sup>	I <sub>DM</sub>	-15.6		A
Operating Junction Temperature	T <sub>J</sub>	-55 to 150		°C
Lead Temperature	T <sub>L</sub>	260		°C
Storage Temperature Range	T <sub>stg</sub>	-55 to 150		°C

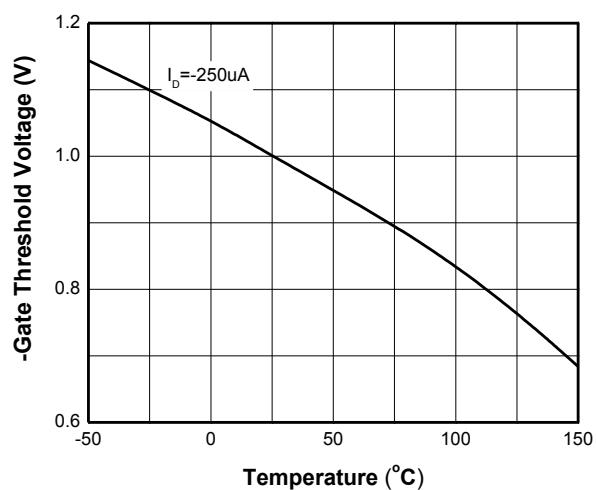
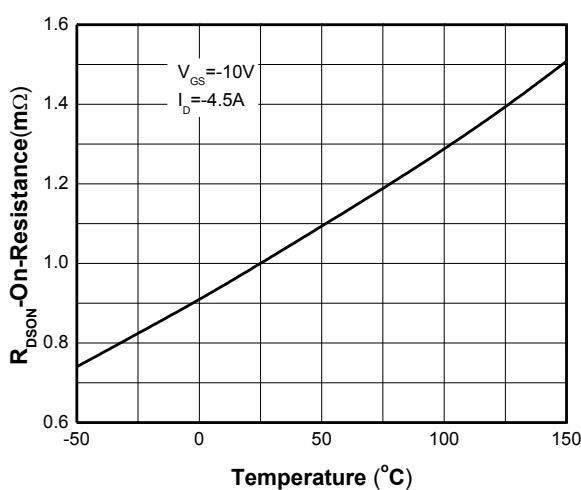
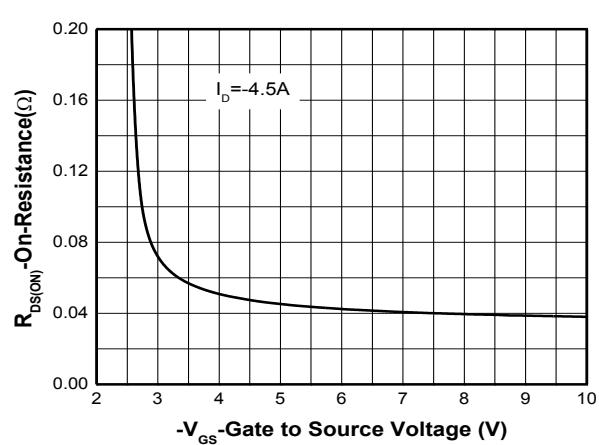
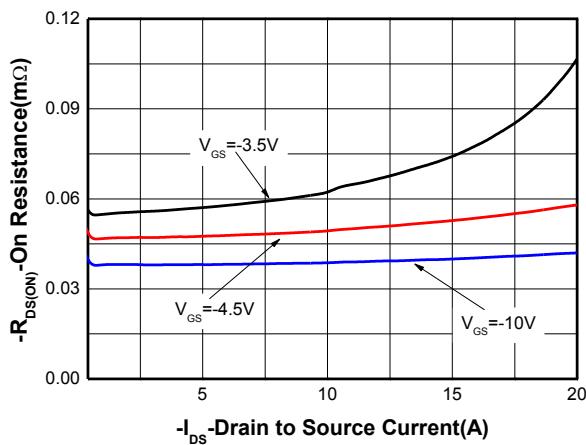
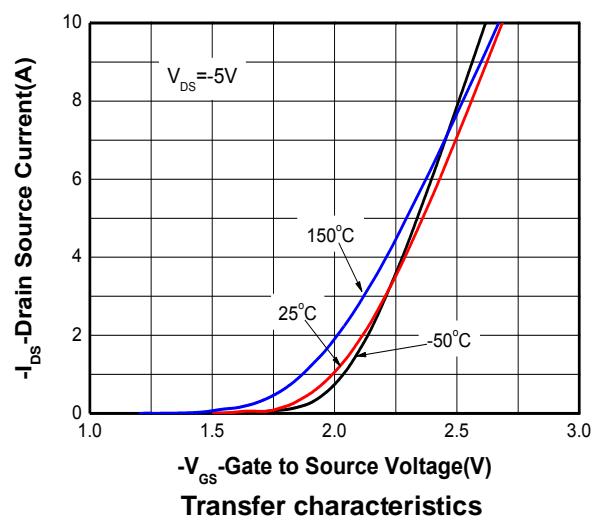
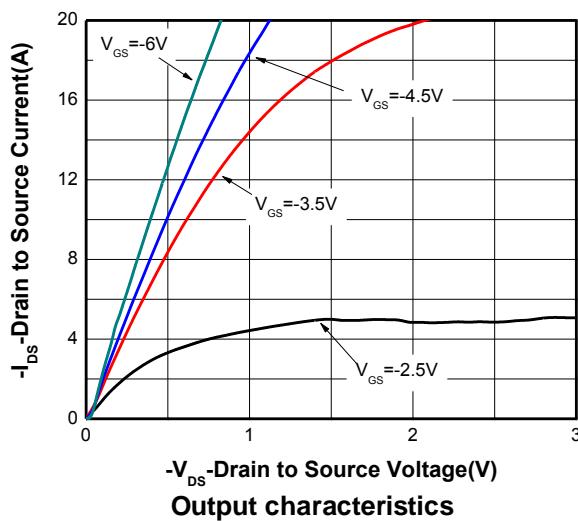
## Thermal resistance ratings

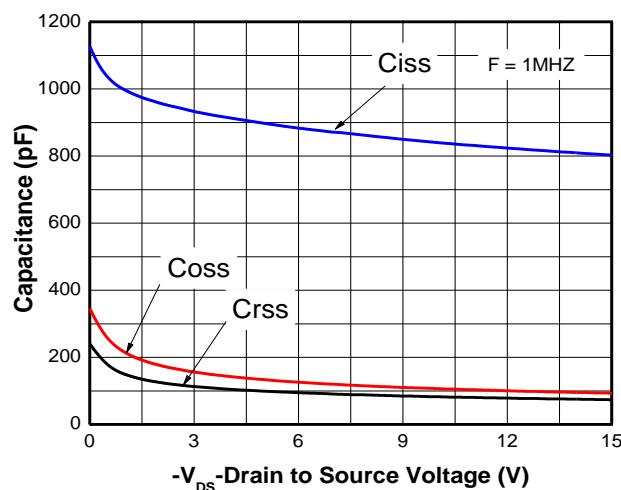
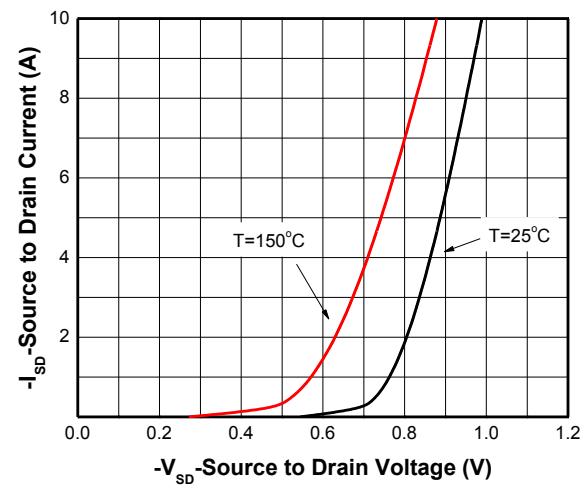
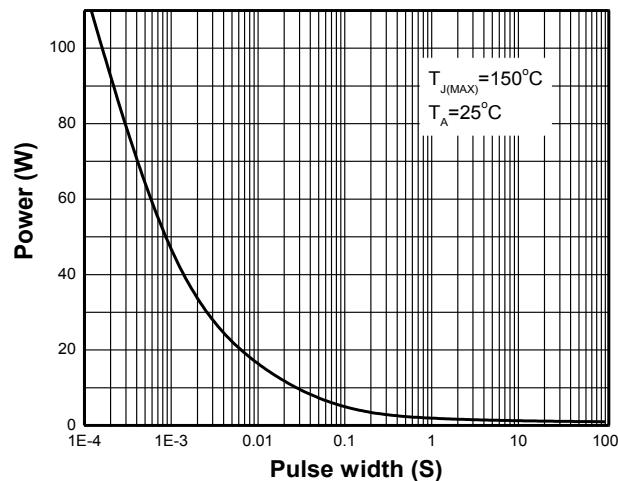
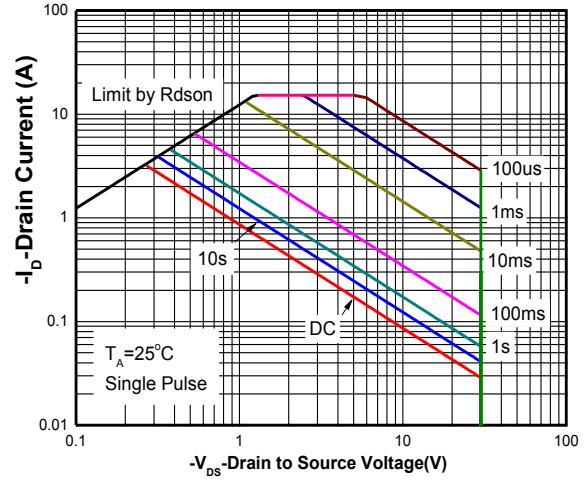
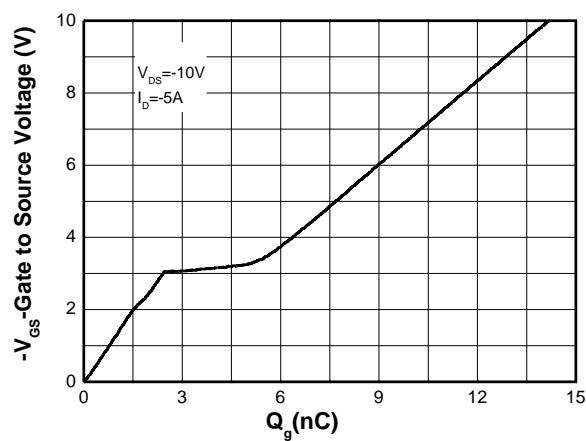
Parameter	Symbol	Typical	Maximum	Unit
Junction-to-Ambient Thermal Resistance <sup>a</sup>	t ≤ 10 s	R <sub>θJA</sub>	84	102
	Steady State		120	145
Junction-to-Ambient Thermal Resistance <sup>b</sup>	t ≤ 10 s	R <sub>θJA</sub>	130	160
	Steady State		145	190
Junction-to-Case Thermal Resistance	R <sub>θJC</sub>	60	75	

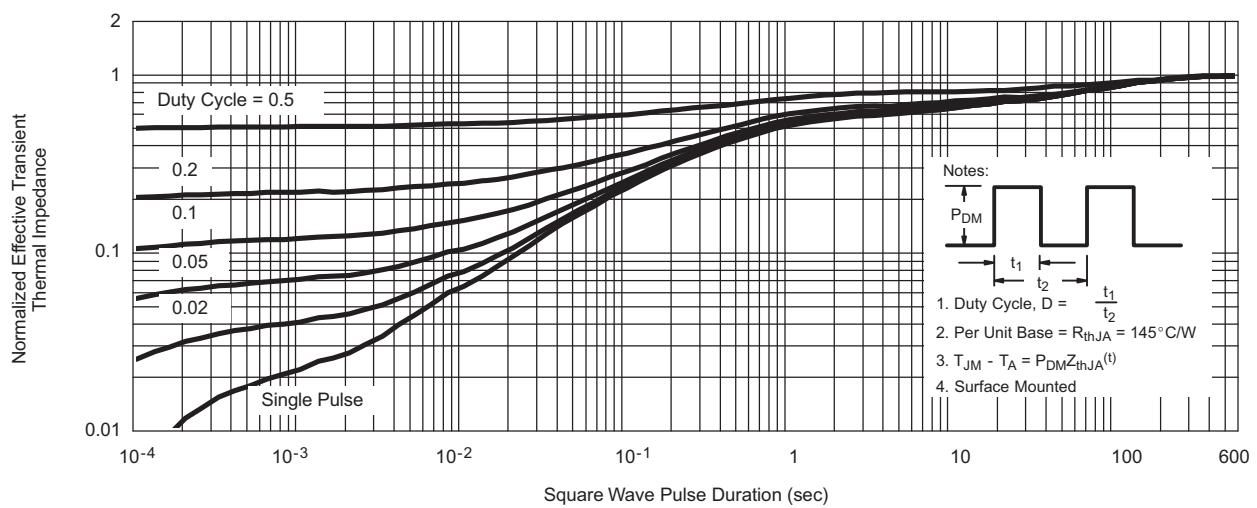
- a. Surface mounted on FR4 Board using 1 in sq pad size, 1oz Cu.
- b. Surface mounted on FR4 board using the minimum recommended pad size, 1oz Cu.
- c. Repetitive rating, pulse width limited by junction temperature, tp=10µs, Duty Cycle=1%.
- d. Repetitive rating, pulse width limited by junction temperature TJ(MAX)=150°C.

**Electronics Characteristics (Ta=25°C, unless otherwise noted)**

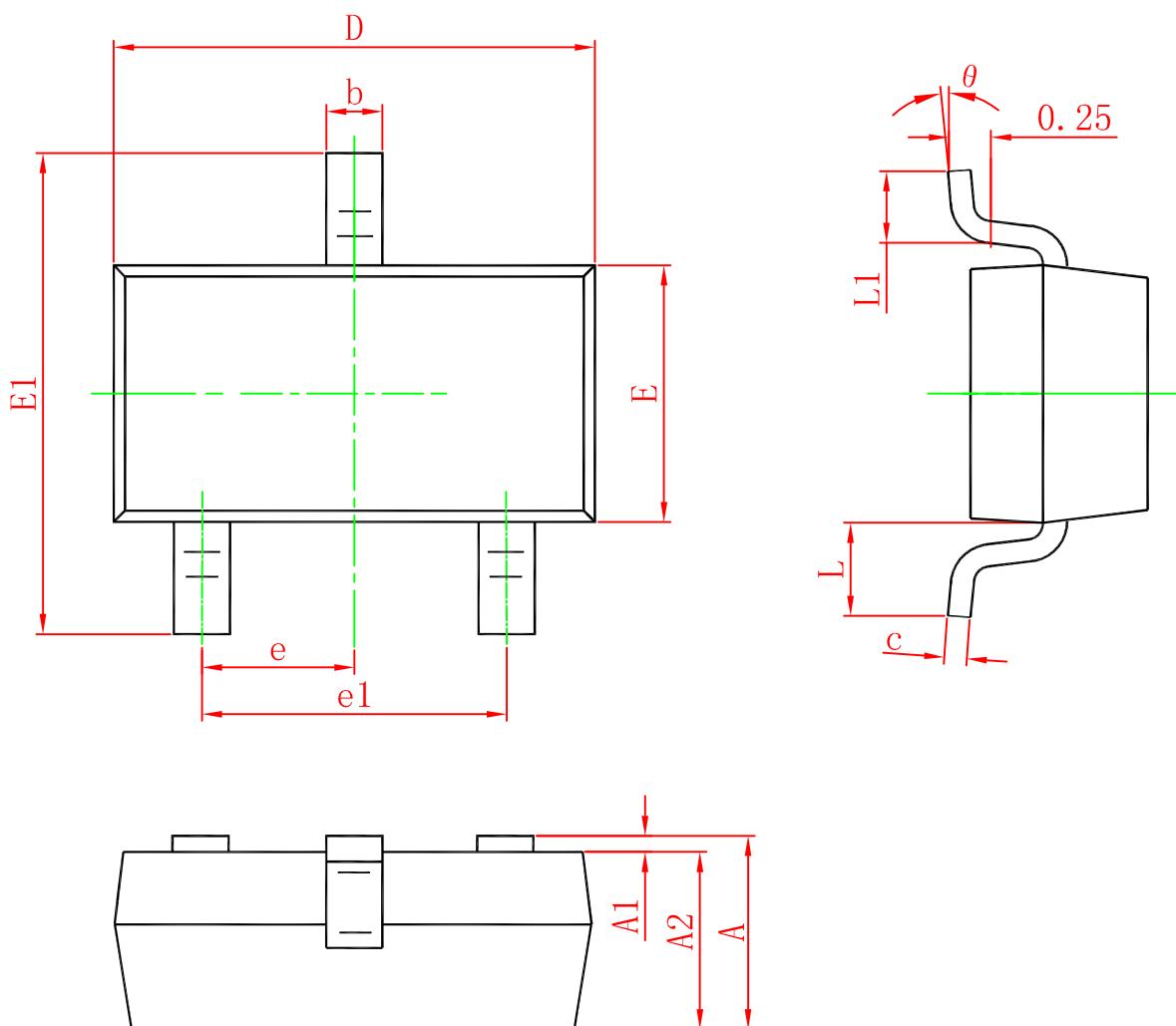
Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>OFF CHARACTERISTICS</b>						
Drain-to-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = -250uA	-30			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -24V, V <sub>GS</sub> = 0V			-1	uA
Gate-to-source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±20V			±100	nA
<b>ON CHARACTERISTICS</b>						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = -250uA	-1.0	-1.8	-3.0	V
Drain-to-source On-resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -10V, I <sub>D</sub> = -4.5A		37	54	mΩ
		V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -4A		50	74	
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> = -5 V, I <sub>D</sub> = -3.3A		4	7	S
<b>CHARGES, CAPACITANCES AND GATE RESISTANCE</b>						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1.0MHz, V <sub>DS</sub> = -15 V		778		pF
Output Capacitance	C <sub>OSS</sub>			85		
Reverse Transfer Capacitance	C <sub>RSS</sub>			68		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = -4.5 V, V <sub>DS</sub> = -10 V, I <sub>D</sub> = -5.0 A		6.8		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>			0.55		
Gate-to-Source Charge	Q <sub>GS</sub>			2.5		
Gate-to-Drain Charge	Q <sub>GD</sub>			2.1		
<b>SWITCHING CHARACTERISTICS</b>						
Turn-On Delay Time	td(ON)	V <sub>GS</sub> = -10 V, V <sub>DD</sub> = -15 V, I <sub>D</sub> = -4A, R <sub>G</sub> = 6Ω		11.2		ns
Rise Time	tr			4.7		
Turn-Off Delay Time	td(OFF)			50		
Fall Time	tf			8		
<b>BODY DIODE CHARACTERISTICS</b>						
Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = -1A	-0.6	-0.75	-1.2	V

**Typical Characteristics (Ta=25°C, unless otherwise noted)**



**Capacitance**

**Body diode forward voltage**

**Single pulse power**

**Safe operating power**

**Gate Charge Characteristics**



**Transient thermal response (Junction-to-Ambient)**

**Package outline dimensions**
**SOT-23**


Symbol	Dimensions In Millimeters	
	Min.	Max.
A	0.900	1.150
A1	0.000	0.100
A2	0.900	1.050
b	0.300	0.500
c	0.080	0.150
D	2.800	3.000
E	1.200	1.400
E1	2.250	2.550
e	0.950 (Typ.)	
e1	1.800	2.000
L	0.550 (Typ.)	
L1	0.300	0.500
θ	0°	8°